# **Small Signal MOSFET**

20 V, 540 mA / -20 V, -430 mA Complementary N- and P-Channel MOSFETs with Integrated Pull Up/Down Resistor and ESD Protection

#### **Features**

- Leading Trench Technology for Low RDS(on) Performance
- High Efficiency System Performance
- Low Threshold Voltage
- Integrated G-S Resistor on Both Devices
- ESD Protected Gate
- Small Footprint 1.6 x 1.6 mm
- These are Pb-Free Devices

### **Applications**

- Load/Power Switching with Level Shift
- Portable Electronic Products such as GPS, Cell Phones, DSC, PMP, Bluetooth Accessories

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise specified)

Dave	meter		Cumala al	Value	Unit	
Para	Symbol	Value	Unit			
Drain-to-Source Voltag	$V_{DSS}$	20	٧			
Gate-to-Source Voltag	V <sub>GS</sub>	±6	V			
N-Channel Continu-	Steady T <sub>A</sub> = 25°C			540		
ous Drain Current (Note 1)	State	$T_A = 85^{\circ}C$		390		
	t ≤ 5 s	T <sub>A</sub> = 25°C	1_	570	mA	
P-Channel Continu-	Steady	$T_A = 25^{\circ}C$	I <sub>D</sub>	-430	IIIA	
ous Drain Current (Note 1)	State	$T_A = 85^{\circ}C$		-310		
	t ≤ 5 s	$T_A = 25^{\circ}C$		-455		
Power Dissipation	Steady		P <sub>D</sub>	250	mW	
(Note 1)	State	State T <sub>A</sub> = 25°C				
	t ≤ 5 s			280		
Pulsed Drain Current	N-Channel	+ 10	1	1500	mA	
	P-Channel	t <sub>p</sub> = 10 μs	I <sub>DM</sub>	-750	IIIA	
Operating Junction and	TJ,	-55 to	°C			
	T <sub>STG</sub>	150				
Source Current (Body D	I <sub>S</sub>	350	mA			
Lead Temperature for S (1/8" from case for 1	TL	260	°C			

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 Surface-mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq [1 oz] including traces).

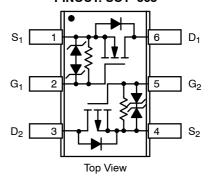


### ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Max	I <sub>D</sub> Max (Note 1)
	0.55 Ω @ 4.5 V	
N-Channel 20 V	0.7 Ω @ 2.5 V	540 mA
20 1	0.9 Ω @ 1.8 V	
2	0.9 Ω @ -4.5 V	
P-Channel -20 V	1.2 Ω @ -2.5 V	–430 mA
= 5	2.0 Ω @ -1.8 V	

#### PINOUT: SOT-563





ZC = Specific Device Code

M = Date Code= Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device Package		Shipping <sup>†</sup>
NTZD3156CT1G	SOT-563	4000 / Tape & Reel
NTZD3156CT2G	SOT-563	4000 / Tape & Reel
NTZD3156CT5G	SOT-563	8000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### **Thermal Resistance Ratings**

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	116	°C/W
Junction-to-Ambient – t = 5 s (Note 2)		304	

<sup>2.</sup> Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

#### **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	N/P	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	N	V <sub>GS</sub> = 0 V	I <sub>D</sub> = 250 μA	20			V
		Р	1	I <sub>D</sub> = -250 μA	-20			
Drain-to-Source Breakdown Voltage Temperature Coefficient	V(BR)DSS/TJ					20		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	N	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V	T <sub>J</sub> = 25°C			1.0	μΑ
		Р	$V_{GS} = 0 \text{ V}, V_{DS} = -16 \text{ V}$	1			-1.0	
		N	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V	T <sub>J</sub> = 125°C			2.0	μΑ
		Р	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = - 16V				-5.0	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	N	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =	±4.5 V			±50	μΑ
		Р	1				±50	
ON CHARACTERISTICS (Note 3)	•				•			
Gate Threshold Voltage	V <sub>GS(TH)</sub>	N	$V_{GS} = V_{DS}$	I <sub>D</sub> = 250 μA	0.45		1.0	V
		Р	1	I <sub>D</sub> = -250 μA	-0.45		-1.0	
Gate Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>					2.0		-mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	N	$V_{GS} = 4.5 \text{ V}, I_D = 540 \text{ mA}$ $V_{GS} = -4.5 \text{ V}, I_D = -430 \text{ mA}$			0.19	0.55	
		Р				0.39	0.9	
		N	$V_{GS} = 2.5 \text{ V}, I_D = 8$	500 mA		0.26	0.7	Ω
		Р	$V_{GS} = -2.5V, I_D = -$	-300 mA		0.53	1.2	
		N	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 3	350 mA		0.36	0.9	
		Р	V <sub>GS</sub> = -1.8V, I <sub>D</sub> = -	-150 mA		0.72	2.0	
Forward Transconductance	9FS	N	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 540 mA			1.46		
		Р	V <sub>DS</sub> = -10 V, I <sub>D</sub> = -	-430 mA		1.18		S
CHARGES, CAPACITANCES AND GA	TE RESISTAN	ICE	•		•	•	•	
Input Capacitance	C <sub>ISS</sub>					72		
Output Capacitance	C <sub>OSS</sub>	N	f = 1 MHz, V <sub>GS</sub> V <sub>DS</sub> = 16 V	= 0 V		13		1
Reverse Transfer Capacitance	C <sub>RSS</sub>	1	v <sub>DS</sub> = 10 v			10		_
Input Capacitance	C <sub>ISS</sub>	1				93		pF
Output Capacitance	C <sub>OSS</sub>	Р	$f = 1 \text{ MHz}, V_{GS} = 0 \text{ V}$ $V_{DS} = -16 \text{ V}$			15		
Reverse Transfer Capacitance	C <sub>RSS</sub>	1				11		

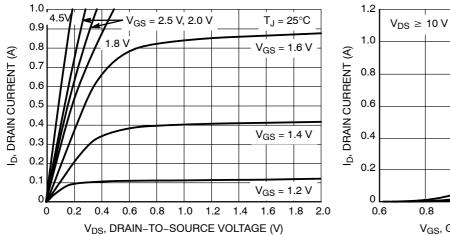
<sup>3.</sup> Pulse Test: pulse width  $\leq\!300~\mu\text{s},$  duty cycle  $\leq\!2\%$ 

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	N/P	Test Conditi	ion	Min	Тур	Max	Unit
CHARGES, CAPACITANCES	AND GATE RES	SISTAN	CE					
Total Gate Charge	Q <sub>G(TOT)</sub>					1.39	2.5	
Threshold Gate Charge	Q <sub>G(TH)</sub>	N	15)/// 10)	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V; I <sub>D</sub> = 540 mA		0.1		
Gate-to-Source Charge	$Q_{GS}$		$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}$			0.26		
Gate-to-Drain Charge	$Q_{GD}$		Ţ			0.39		0
Total Gate Charge	Q <sub>G(TOT)</sub>					1.49	2.5	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	P	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}$	V; I <sub>D</sub> = -430 mA		0.1		
Gate-to-Source Charge	$Q_{GS}$	1 "		_		0.3		
Gate-to-Drain Charge	$Q_GD$	1				0.37		
SWITCHING CHARACTERIST	TICS (V <sub>GS</sub> = V)	Note 4	)	-		-		-
Turn-On Delay Time	t <sub>d(ON)</sub>	N				7.7		
Rise Time	t <sub>r</sub>	1	V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 10 V	Vcs = 4.5 V. Vpp = 10 V. lp = 540 mA.		5.3		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	1	$V_{GS}$ = 4.5 V, $V_{DD}$ = 10 V, $I_{D}$ = 540 mA, $R_{G}$ = 10 $\Omega$			21		
Fall Time	t <sub>f</sub>	1				10		1
Turn-On Delay Time	t <sub>d(ON)</sub>	Р	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V}, I_D = -430 \text{ mA},$			9.2		ns
Rise Time	t <sub>r</sub>	1				6.5		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	1	$R_{\rm G} = 10  \Omega$	2		29		
Fall Time	t <sub>f</sub>	1				19.5		
Drain-Source Diode Charact	eristics							-
Forward Diode Voltage	V <sub>SD</sub>	N	V 0V T 0500	I <sub>S</sub> = 350 mA		0.77	1.2	
		Р	$V_{GS} = 0 \text{ V, } T_J = 25^{\circ}\text{C}$ $I_S = -350 \text{ m/s}$ $I_S = 350 \text{ m/s}$			-0.77	-1.2	1 ,,
		N				0.65		٧
		Р	$V_{GS} = 0 \text{ V}, T_{J} = 125^{\circ}\text{C}$	$I_{S} = -350 \text{ mA}$		0.63		
Reverse Recovery Time	t <sub>RR</sub>	N	V <sub>GS</sub> = 0 V,	I <sub>S</sub> = 350 mA		9.4		
		Р	dIS/dt = 100 A/μs	$I_{S} = -350 \text{ mA}$		14.6		ns

<sup>4.</sup> Switching characteristics are independent of operating junction temperatures

### N-CHANNEL TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)



V<sub>DS</sub>, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

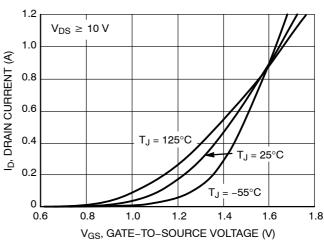


Figure 2. Transfer Characteristics

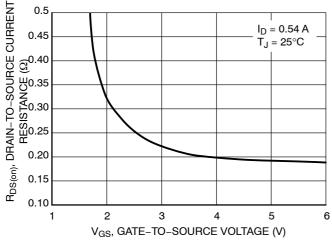


Figure 3. On-Resistance versus Gate-to-Source Voltage

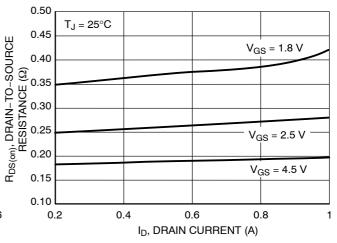


Figure 4. On-Resistance versus Drain Current and Gate Voltage

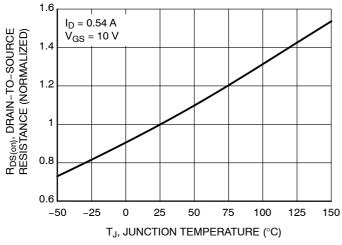


Figure 5. On–Resistance Variation with Temperature

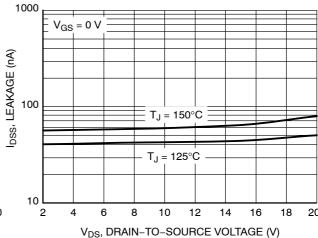


Figure 6. Drain-to-Source Leakage Current versus Voltage

# $\textbf{N-CHANNEL TYPICAL PERFORMANCE CURVES} \ \, (T_J = 25^{\circ}\text{C unless otherwise noted})$

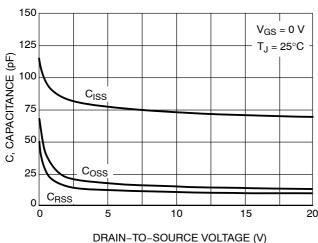
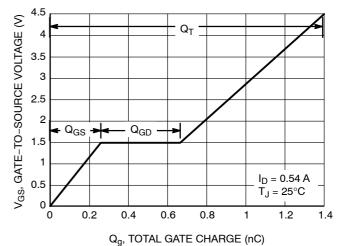


Figure 7. Capacitance Variation



Qg, TOTAL GATE OTTAHGE (IIO)

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

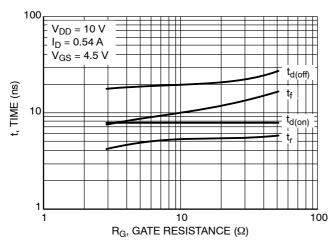


Figure 9. Resistive Switching Time Variation versus Gate Resistance

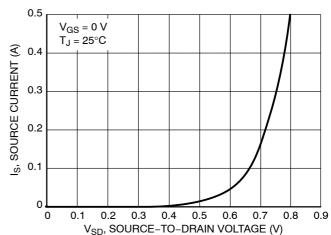


Figure 10. Diode Forward Voltage versus Current

### P-CHANNEL TYPICAL PERFORMANCE CURVES (T<sub>J</sub> = 25°C unless otherwise noted)

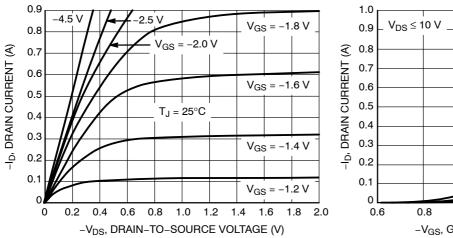


Figure 11. On-Region Characteristics

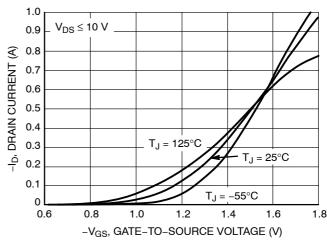


Figure 12. Transfer Characteristics

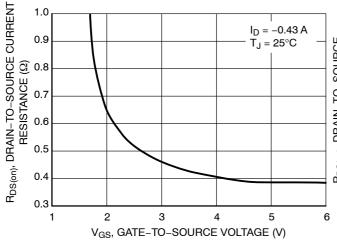


Figure 13. On-Resistance versus Gate-to-Source Voltage

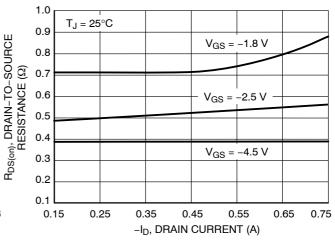


Figure 14. On-Resistance versus Drain Current and Gate Voltage

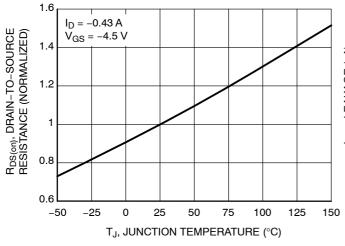


Figure 15. On–Resistance Variation with Temperature

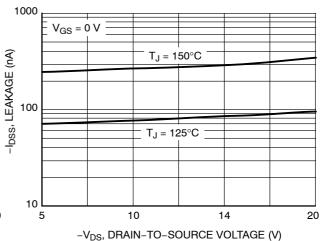
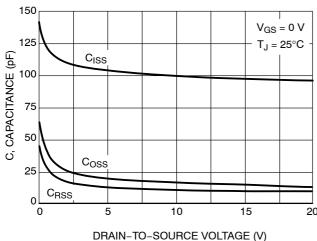


Figure 16. Drain-to-Source Leakage Current versus Voltage

# $\textbf{P-CHANNEL TYPICAL PERFORMANCE CURVES} \ \, (T_J = 25^{\circ}C \ \, \text{unless otherwise noted})$



- Diving to coolide volintae (v)

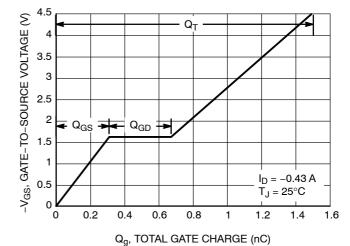


Figure 18. Gate-to-Source and Drain-to-Source Voltage versus Total Charge



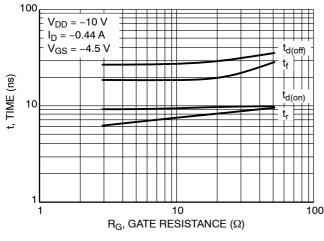


Figure 19. Resistive Switching Time Variation versus Gate Resistance

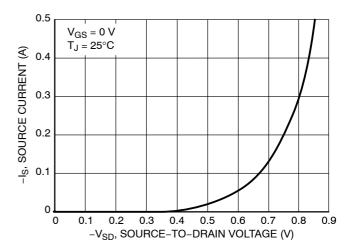


Figure 20. Diode Forward Voltage versus Current

# MECHANICAL CASE OUTLINE

PACKAGE DIMENSIONS



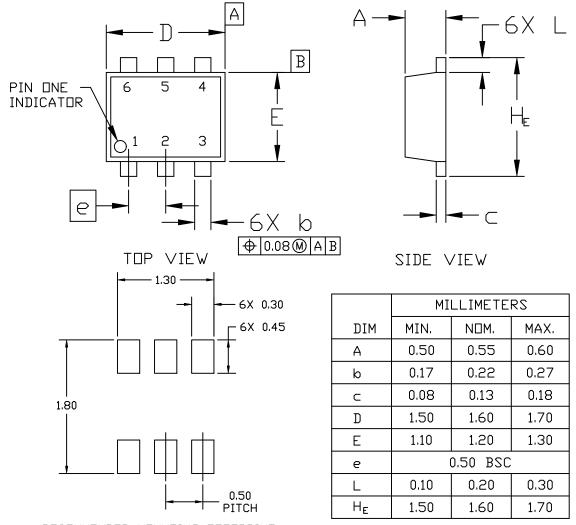


#### SOT-563, 6 LEAD CASE 463A ISSUE H

**DATE 26 JAN 2021** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.



#### RECOMMENDED MOUNTING FOOTPRINT\*

For additional information on our Pb-Free strategy and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

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### **SOT-563, 6 LEAD**

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**DATE 26 JAN 2021** 

STYLE 1: PIN 1. EMITTER 1 2. BASE 1 3. COLLECTOR 2 4. EMITTER 2 5. BASE 2 6. COLLECTOR 1	STYLE 2: PIN 1. EMITTER 1 2. EMITTER 2 3. BASE 2 4. COLLECTOR 2 5. BASE 1 6. COLLECTOR 1	STYLE 3: PIN 1. CATHODE 1 2. CATHODE 1 3. ANODE/ANODE 4. CATHODE 2 5. CATHODE 2 6. ANODE/ANODE
STYLE 4: PIN 1. COLLECTOR 2. COLLECTOR 3. BASE 4. EMITTER 5. COLLECTOR 6. COLLECTOR	STYLE 5: PIN 1. CATHODE 2. CATHODE 3. ANODE 4. ANODE 5. CATHODE 6. CATHODE	STYLE 6: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. CATHODE 5. CATHODE 6. CATHODE
STYLE 7: PIN 1. CATHODE 2. ANODE 3. CATHODE 4. CATHODE 5. ANODE 6. CATHODE	STYLE 8: PIN 1. DRAIN 2. DRAIN 3. GATE 4. SDURCE 5. DRAIN 6. DRAIN	STYLE 9: PIN 1. SDURCE 1 2. GATE 1 3. DRAIN 2 4. SDURCE 2 5. GATE 2 6. DRAIN 1
STYLE 10: PIN 1. CATHODE 1 2. N/C 3. CATHODE 2 4. ANODE 2 5. N/C 6. ANODE 1	STYLE 11: PIN 1. EMITTER 2 2. BASE 2 3. COLLECTOR 1 4. EMITTER 1 5. BASE 1 6. COLLECTOR 2	

# GENERIC MARKING DIAGRAM\*



XX = Specific Device CodeM = Month Code= Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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